

EMC TEST REPORT

ETSI EN 301 489-1 V2.2.3 (2019-11) ETSI EN 301 489-3 V2.1.1 (2019-03) ETSI EN 301 489-17 V3.2.4 (2020-09)

EN 55032:2015+A1:2020 EN 55035:2017+A11:2020

EN IEC 61000-3-2:2019+A1:2021 EN 61000-3-3:2013+A2:2021

Product: Tablet PC

Trade Mark: Blackview, OSCAL

Model Name: Tab 8 WiFi

Family Model: Tab 8 Kids, Pad 70

Report No.: STR230303001006E

Prepared for

DOKE COMMUNICATION (HK) LIMITED

RM 1902 EASEY COMM BLDG 253-261 HENNESSY ROAD

WANCHAI HK CHINA

Prepared by

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TEST RESULT CERTIFICATION

Applicant's Name DOKE COMMUNICATION (HK) LIMITED

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WANCHAI HK CHINA

Manufacturer's Name: Shenzhen DOKE Electronic Co.,Ltd

801, Building3, 7th Industrial Zone, Yulv Community, Yutang Address

Road, Guangming District, Shenzhen, China

Product description

Product Name Tablet PC

Trade Mark: Blackview, OSCAL

Model Name Tab 8 WiFi

Family Model Tab 8 Kids, Pad 70

Standards ETSI EN 301 489-1 V2.2.3 (2019-11)

ETSI EN 301 489-3 V2.1.1 (2019-03) ETSI EN 301 489-17 V3.2.4 (2020-09)

EN 55032:2015+A1:2020; EN 55035:2017+A11:2020

EN IEC 61000-3-2:2019+A1:2021;EN 61000-3-3:2013+A2:2021

Report No.: STR230303001006E

This device described above has been tested by NTEK, and the test results show that the equipment under test (EUT) is in compliance with the of article 3.1(b) of the Directive 2014/53/EU requirements. And it is applicable only to the tested sample identified in the report.

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Test Sample Number T230303001R001

Date of Test

Date (s) of performance of tests: Mar 08. 2023 ~ Apr 07. 2023

Date of Issue: Apr 10. 2023

Test Result: **Pass**

> Allen. Huang (Allen Huang) Testing Engineer

Authorized Signatory

(Alex Li)





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1. TEST SUMMARY

Test procedures according to the technical standards:

ETSI EN 301 489-1 V2.2.3 (2019-11)

ETSI EN 301 489-3 V2.1.1 (2019-03)

ETSI EN 301 489-17 V3.2.4 (2020-09)

EN 55032:2015+A1:2020; EN 55035:2017+A11:2020

EN IEC 61000-3-2:2019+A1:2021;EN 61000-3-3:2013+A2:2021

EMC Emission

Standard	Test Item	Limit	Judgment	Remark
of Sign	Conducted Emission On AC And Telecom Port 150kHz to 30MHz	Class B	PASS	
	Disturbance Voltage at The Antenna Terminals (30MHz To 2150MHz)		N/A	*
EN 55032:2015+A1:2020	Wanted signal and disturbance voltage at the RF output terminals (30MHz To 2150MHz)	<u> </u>	N/A	
	Radiated Emission 30MHz to 1000MHz	Class B	PASS	\$
	Radiated Emission 1GHz to 6GHz	Class B	PASS	⋆
EN IEC 61000-3-2:2019+A1:20 21	Harmonic Current Emission	Class A	N/A	
EN 61000-3-3:2013+A2:20 21	Voltage Fluctuations & Flicker	4	PASS	F (

EMC Immunity

Section EN 55035:2017+A11:2020	Test Item	Performance Criteria	Judgment	Remark
EN 61000-4-2:2009	Electrostatic Discharge	В	PASS	
EN 61000-4-3:2006+ A1:2008+A2:2010	RF electromagnetic field	А	PASS	
EN 61000-4-4:2012	Fast transients	В	PASS	
EN 61000-4-5:2014+ A1:2017	Surges	В	PASS	
EN 61000-4-6:2014	Continuous radio frequency disturbances or Injected Current	А	PASS	
EN 61000-4-8:2010	Power Frequency Magnetic Field	A	N/A	NOTE (3)
EN 61000-4-11:2004	Volt. Interruptions Volt. Dips	B/C/C NOTE (2)	PASS	



NOTE:

(1)" N/A" denotes test is not applicable in this Test Report

(2) Voltage dip: 100% reduction – Performance Criteria **B** Voltage dip: 30% reduction – Performance Criteria **C**

Voltage Interruption: 100% Interruption – Performance Criteria C

- (3) Applicable only to equipment containing devices intrinsically susceptible to magnetic fields, such as CRT monitors, Hall effect elements, electro-dynamic microphones, magnetic field sensors or audio frequency transformers.
- (4) For client's request and manual description, the test will not be executed.

N2017.03.22.0322.V.1.0





1.1 TEST FACILITY

Shenzhen NTEK Testing Technology Co., Ltd.

Add.: 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street Bao'an District,

Shenzhen 518126 P.R. China

CNAS-Lab. : The Certificate Registration Number is L5516

IC-Registration : The Certificate Registration Number is CN0074

FCC- Accredited : Test Firm Registration Number: 463705

Designation Number: CN1184

A2LA-Lab. : The Certificate Registration Number is 4298.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for

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the competence of testing and calibration laboratories.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expended uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of $\mathbf{k=2}$, providing a level of confidence of approximately $\mathbf{95}$ %.

Test Item	Measurement Frequency Range	K	U(dB)
AC Mains Conducted Emission	0.009kHz ~ 0.15MHz	2	2.66
AC Mains Conducted Emission	0.15MH ~ 30MHz	2	2.80
Telecom Conducted Emission(Cat 3)	0.15MHz ~ 30MHz	2	2.40
Telecom Conducted Emission(Cat 5)	0.15MHz ~ 30MHz	2	2.58
Radiated Emission	30MHz ~ 1000MHz	2	5.10
Radiated Emission	1000MHz ~ 6000MHz	2	2.40
Radiated Emission	6000MHz ~ 18000MHz	2	2.52



Revision History

Report No.	Version	Description	Issued Date
STR230303001006E	Rev.01	Initial issue of report	Apr 10. 2023
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2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Z. I GENERAL DESCRIP	TION OF EUT
Equipment	Tablet PC
Trade Mark	Blackview, OSCAL
Model Name	Tab 8 WiFi
Family Model	Tab 8 Kids, Pad 70
Model Difference	All the model are the same circuit and RF module, except the Trade Mark.
	⊠BT: 2402 ~ 2480 MHz
2 4.	⊠2.4G WIFI: 802.11b/g/n(20MHz)/ax20: 2412 ~ 2472MHz
	802.11n(40MHz)/ax40:2422~2462MHz
L 3	⊠5G WIFI:802.11a/ n(20/40)/ ac(20/40/80)/ ax(20/40/80):
- 10 +	5180MHz~5240MHz;(20MHz)
Frequency Bands	5190MHz~5230MHz;(40MHz)
,L	5210MHz;(80MHz)
	5745-5825 MHz for 802.11a/n20/ac20/ax20;
	5755-5795 MHz for 802.11n40/ac40/ax40;
4,	5775MHz for 802.11 ac80/ax80;
4	⊠BT(1Mbps)/BLE: GFSK
	⊠BT EDR(2Mbps): π/4-DQPSK
	⊠BT EDR(3Mbps): 8-DPSK
3	⊠BLE(2Mbps):GFSK
Modulation Mode	☑IEEE 802.11b: DSSS (CCK, DQPSK, DBPSK) ☑IEEE 802.11g/n (HT20/HT40) /ax20/ax40: OFDM (64QAM, 16QAM, QPSK, BPSK) ☑IEEE802.11a: OFDM (BPSK / QPSK / 16QAM) ☑IEEE802.11n: OFDM (QPSK/BPSK/16QAM/64QAM) ☑IEEE802.11ac: OFDM (QPSK/BPSK/16QAM/64QAM/256QAM) ☑IEEE802.11ax: OFDM (QPSK/BPSK/16QAM/64QAM/256QAM/1024QAM)
Adapter	Model: QZ-01000EA00 Input: 100-240V~50/60Hz 0.3A Output: 5.0V2.0A (10.0W)
Battery	Battery 1: DC 3.8V, 6580mAh Battery 2: DC 3.8V, 6580mAh
Power Rating	DC 3.8V from battery or DC 5V from Adapter.





Connecting I/O Port(s)	Please refer to the User's Manual			
Antenna	PIFA Antenna		4	
Hardware Version	R863T-RK3566-DK-V1.0	4		
Software Version	Tab_8_WiFi_EEA_S863T_V1.0 Tab_8_Kids_EEA_S863T_V1.0 PAD_70_EEA_S863T_V1.0	ot-	Significant of the second	4



2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Charging + TF Playing
Mode 2	Data transmission
Mode 3	Charging + REC(Rear / Front)
Mode 4	BT LINK
Mode 5	2.4G WIFI
Mode 6	5G WIFI

For Conducted Test		
Final Test Mode Description		
Mode 1	Charging + TF Playing	

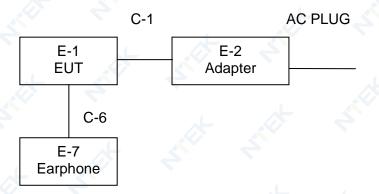
	For Radiated Test	*
Final Test Mode	Description	
Mode 1	Charging + TF Playing	
Mode 2	Data transmission	

For EMS Test		
Pretest Mode	Description	
Mode 1	Charging + TF Playing	
Mode 2	Data transmission	
Mode 3	Charging + REC(Rear / Front)	
Mode 4	BT LINK	
Mode 5	2.4G WIFI	
Mode 6	5G WIFI	

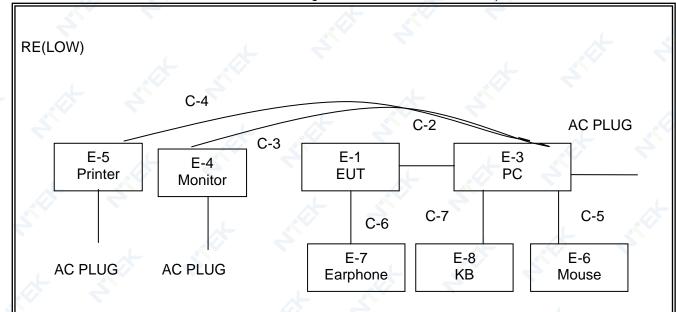
NOTE: The test modes were carried out for all operation modes. The final test mode of the EUT was the worst test mode for EMI, and its test data was showed.



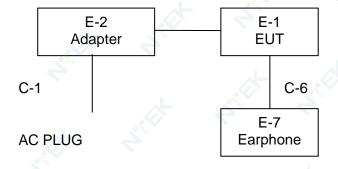
2.3 DESCRIPTION OF TEST SETUP CE







RE(HIGH)





2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Model/Type No.	Series No.	Note
E-1	Tablet PC	Tab 8 WiFi	N/A	EUT
E-2	Adapter	QZ-01000EA00	N/A	Peripherals
E-3	PC	N/A	N/A	Peripherals
E-4	Monitor	N/A	N/A	Peripherals
E-5	Printer	N/A	N/A	Peripherals
E-6	Mouse	N/A	N/A	Peripherals
E-7	Earphone	N/A	N/A	Peripherals
E-8	KB	N/A	N/A	Peripherals
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Item	Cable Type	Shielded Type	Ferrite Core	Length	Note
C-1	USB Cable	NO	NO	1.2m	
C-2	USB Cable	NO	NO	1.2m	
C-3	HDMI Cable	YES	YES	1.0m	
C-4	USB Cable	NO	NO	1.2m	
C-5	USB Cable	NO	NO	1.2m	4,
C-6	Earphone Cable	NO	NO	1.5m	
C-7	USB Cable	NO	NO	1.2m	
					- A
			4	*	

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in <code>"Length_"</code> column.



2.5 MEASUREMENT INSTRUMENTS LIST

2.5.1CONDUCTED EMISSION

	Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
	1	Test Cable	N/A	C01	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	2	Test Cable	N/A	C02	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	3	Test Cable	N/A	C03	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
	4	Pulse Limiter	SCHWARZBE CK	VTSD 9561F	9716	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
	5	50Ω Switch	ANRITSU CORP	MP59B	620098370 4	May. 11, 2021	May. 10, 2024	3 year
	6	EMI Test Receiver	R&S	ESCI	101160	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
	7	Unversal radio communication tester	R&S	CMU200	1100.008.0	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
	8	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
•	9	LISN	SCHWARZBE CK	NNLK 8129	8129245	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
	10	LISN	R&S	ENV216	101313	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year



2.5.2 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Antenna Mast	EM	SC100_1	N/A	N/A	N/A	N/A
2	Turn Table	EM	SC100	060531	N/A	N/A	N/A
3	EMI Test Receiver	R&S	ESCI-7	101318	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
4	50Ω Switch	Anritsu Corp	MP59B	620098370 5	May. 11, 2021	May. 10, 2024	3 year
5	Spectrum Analyzer	Aglient	E4407B	MY451080 40	Apr .01, 2022 Mar .27, 2023	Mar .31 2023 Mar .26, 2024	1 year
6	Unversal radio communication tester	R&S	CMU200	1100.008.0	Jun.16, 2022	Jun.15, 2023	1 year
7	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun.16, 2022	Jun.15, 2023	1 year
8	Test Cable	N/A	R-01	N/A	Jun. 17, 2022	Jun. 16, 2025	3 years
9	Test Cable	N/A	R-02	N/A	Jun. 17, 2022	Jun. 16, 2025	3 years
10	Bilog Antenna	TESEQ	CBL6111D	31216	Mar. 30, 2022 Mar .27, 2023	Mar. 29, 2023 Mar .26, 2024	1 year
11	Horn Antenna	EM	EM-AH-101 80	201107140	Jan. 12, 2023	Jan. 11, 2024	1 year
12	Amplifier	EMC	EMC05183 5SE	980246	Jun.17, 2022	Jun.16, 2023	1 year



2.5.3 HARMONICS AND FILCK

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
2	AC Power Source	EM TEST	ACS500	0203-01	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
3	Unversal radio communication tester	R&S	CMU200	1100.008.0	Jun. 16, 2022	Jun. 15, 2023	1 year
4	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year

2.5.4 ESD

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0	Jun. 16, 2022	Jun. 15, 2023	1 year
2	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year
3	Electrostatic Discharge Generator	Lioncel	ESD-203B	ESD203B0 150402	Jun. 16, 2022	Jun. 15, 2023	1 year

2.5.5 RS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0	Jun. 16, 2022	Jun. 15, 2023	1 year
2	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year
3	Audio Power Amplifier	Brüel & Kjær	4602B	2185667	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
4	Mouth Simulator	Brüel & Kjær	2669	2143265	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
5	Sound Calibrator	Brüel & Kjær	4185	2194825	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
6	1/2" Pressure- field Microphone	Brüel & Kjær	735	2641678	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
7	Telephone Test Head	Brüel & Kjær	4185	2631728	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
8	Audio Analyzer	R&S	UPV	100419	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year



Ear Simulator for Apr .06, 2022 Apr .05, 2023 Brüel & Kjær 4185 2553612 1 year Telephonometr Mar .27, 2023 Mar .26, 2024 3142E(Fequ ency range 10 **ETS** 00214344 Mar. 30, 2022 Jun. 29, 2023 Bilog Antenna 1 year 30MHz to 6 GHz) Broadband AR 60S1G6 0350414 Jun. 26, 2022 Jun. 25, 2023 11 1 year Amplifier MXG Vector MY470703 12 Signal Jun. 16, 2022 Agilent Jun. 15, 2023 1 year N5182A Generator 17 NTWPA-00 17063153 Jun. 17, 2022 13 **Power Amplifier** rflight Jun. 16, 2023 1 year 810200 25S1G4A 14 Power Amplifier AR 308598 Jun. 17, 2022 Jun. 16, 2023 1 year MY451025 15 **Power Meter** Agilent E4419B Jun. 17, 2022 Jun. 16, 2023 1 year 38 MY414956 16 Power Sensor E9301A Jun. 17, 2022 Jun. 16, 2023 Agilent 1 year 44 US392121 17 **Power Sensor** Agilent E9301A Jun. 17, 2022 Jun. 16, 2023 1 year 48

2.5.6 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Surge Generator	EVERFINE	EMS61000- 5A-V1	1101002	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
2	DIPS Generator	EVERFINE	EMS61000- 11K	1011002	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
3	EFT/B Generator	EVERFINE	EMS61000- 4A-V2	1012005	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
4	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun. 16, 2022	Jun. 15, 2023	1 year
5	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun. 16, 2022	Jun. 15, 2023	1 year

2.5.7 INJECTION CURRENT

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Attenuator	TESEQ	ATN 6075	38411	N/A	N/A	N/A
2	RF Cable	TESEQ	RF Cable	N/A	N/A	N/A	N/A
3	Signal Generator	R&S	SML03	100954	Nov.10, 2021 Nov.01, 2022	Nov. 09, 2022 Oct.31, 2023	1 year
4	Power Amplifier	TESEQ	CBA 230M-080	T44376	Jun. 16, 2022	Jun. 15, 2023	1 year
5	EM Clamp	FCC	F-203I-23M M	504	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
6	Audio Power Amplifier	Brüel & Kjær	4602B	2185667	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year



7	Mouth Simulator	Brüel & Kjær	2669	2143265	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
8	Sound Calibrator	Brüel & Kjær	4185	2194825	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
9	1/2" Pressure- field Microphone	Brüel & Kjær	735	2641678	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
10	Audio Analyzer	R&S	UPV	100419	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
11	Ear Simulator for Telephonometr y	Brüel & Kjær	4185	2553612	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
12	Telephone Test Head	Brüel & Kjær	4185	2631728	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year
13	Unversal radio communication tester	R&S	CMU200	1100.008.0	Jun .16, 2022	Jun .15, 2023	1 year
14	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun .16, 2022	Jun .15, 2023	1 year
15	Coupling and Decoupling Network	TESEQ	CDN M016	38722	Apr .06, 2022 Mar .27, 2023	Apr .05, 2023 Mar .26, 2024	1 year



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT 3.1.1 POWER LINE CONDUCTED EMISSION

(Frequency Range 150kHz-30MHz)

Report No.: STR230303001006E

Table A.8 - Requirements for conducted emissions from the AC mains power ports of Class A equipment

Applicabl 1. AC main	e to ns power ports (3.1.1)				
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A limits dB(μV)	
A8.1	0,15 - 0,5	A1401	Overi Beel (OM)	79	
		Quasi Peak / 9 kHz	73		
A8.2	0,15 - 0,5	AAA1	A	66	
	0,5 - 30	AMN	Average / 9 kHz	60	

Table A.9 - Requirements for conducted emissions from the AC mains power ports of Class B equipment

Applicabl I. AC mai	ns power ports (3.1.1)			
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class B limits dB(µV)
A9.1	0,15 - 0,5	· ()		66 – 56
	0,5 – 5	AMN	Quasi Peak / 9 kHz	56
.1	5 – 30			60
A9.2	0,15 - 0,5			56 – 46
	0,5 – 5	AMN	Average / 9 kHz	46
	5 – 30			50

Note:

- The tighter limit applies at the band edges. (1)
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.



3.1.2 TELECOMMUNICATION PORT CONDUCTED EMISSION(VOLTAGE LIMITS) (Frequency Range 150kHz-30MHz)

Table A.10 - Requirements for asymmetric mode conducted emissions from Class A equipment

Applicable to

- wired network ports (3.1.30)
 optical fibre ports (3.1.24) with metallic shield or tension members
 antenna ports (3.1.3)

Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A voltage limits dB(μV)	Class A current limits dB(µA)
A10.1	0,15 - 0,5	AANI	O: D / O.I.I.	97 – 87	
	0,5 – 30	AAN	Quasi Peak / 9 kHz	87	/
	0,15 - 0,5	A A N I	A	84 – 74	n/a
	0,5 – 30	AAN	Average / 9 kHz	74	
A10.2	0,15 - 0,5	CVP	0 : D : / 0 ! !	97 – 87	53 – 43
	0,5 – 30	and current probe	Quasi Peak / 9 kHz	87	43
	0,15 - 0,5	CVP	. 1	84 – 74	40 – 30
	0,5 – 30	and current probe	Average / 9 kHz	74	30
A10.3	0,15 - 0,5	Owner the Deep to			53 – 43
	0,5 – 30	Current Probe	Quasi Peak / 9 kHz	-1-	43
0,15	0,15 - 0,5	Owner Death		n/a	40 – 30
	0,5 – 30	Current Probe	Average / 9 kHz		30

The choice of coupling device and measurement procedure is defined in Annex C.

AC mains ports that also have the function of a wired network port shall meet the limits given in Table A.8.

The test shall cover the entire frequency range.

The application of the voltage and/or current limits is dependent on the measurement procedure used. Refer to Table C.1 for applicability.

Testing is required at only one EUT supply voltage and frequency.

Applicable to ports listed above and intended to connect to cables longer than 3 m.



Table A.12 – Requirements for conducted differential voltage emissions from Class B equipment

Report No.: STR230303001006E

Applicable to

- 1. TV broadcast receiver tuner ports (3.1.8) with an accessible connector
- 2. RF modulator output ports (3.1.27)
- 3. FM broadcast receiver tuner ports (3.1.8) with an accessible connector

Table clause	Frequency range	Detector type/ bandwidth		Class B lim dB(μV) 75	Applicability	
<u> </u>	MHz			Local Oscillator Fundamental		Local Oscillator Harmonics
A12.1	30 – 950		46	46	46	See a)
	950 – 2 150	For frequencies ≤1 GHz	46	54	54	
A12.2	950 – 2 150		46	54	54	See b)
A12.3	30 – 300	Quasi Peak/ 120 kHz	46	54	50	See c)
	300 – 1 000	*			52	
A12.4	30 – 300	For frequencies	46	66	59	See d)
	300 – 1 000	≥1 GHz			52	
A12.5	30 – 950	Peak/ 1 MHz	46	76	46	See e)
	950 – 2 150			n/a	54	

- a) Television receivers (analogue or digital), video recorders and PC TV broadcast receiver tuner cards working in channels between 30 MHz and 1 GHz, and digital audio receivers.
- b) Tuner units (not the LNB) for satellite signal reception.
- c) Frequency modulation audio receivers and PC tuner cards.
- d) Frequency modulation car radios.
- e) Applicable to EUTs with RF modulator output ports (for example DVD equipment, video recorders, camcorders and decoders etc.) designed to connect to TV broadcast receiver tuner ports.

Testing is required at only one EUT supply voltage and frequency.

The term 'other' refers to all emissions other than the fundamental and the harmonics of the local oscillator.

The test shall be performed with the device operating at each reception channel.

The test shall cover the entire frequency range.

The following table is the setting of the receiver

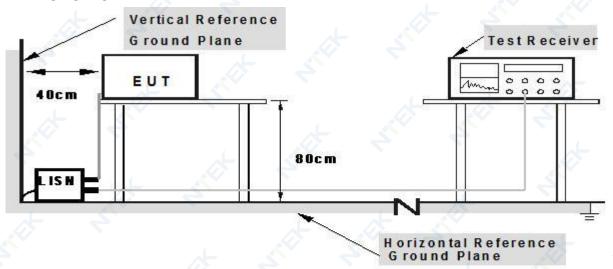
Receiver Parameters	Setting		
Attenuation	10 dB		
Start Frequency	0.15 MHz		
Stop Frequency	30 MHz		
IF Bandwidth	9 kHz		



3.1.3 TEST PROCEDURE

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

3.1.4 TEST SETUP



Note: 1.Support units were connected to second LISN.

2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.2 Unless otherwise a special operating condition is specified in the follows during the testing.



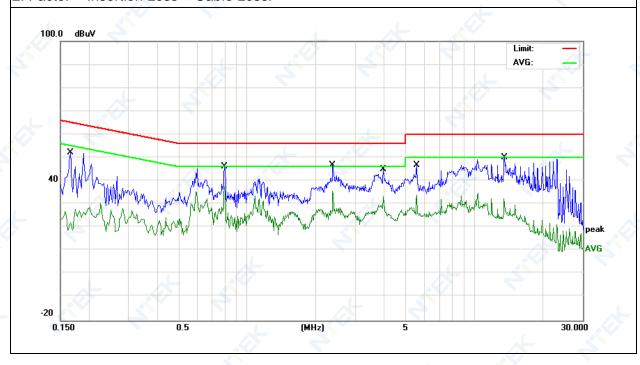
3.1.6 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21.5℃	Relative Humidity:	53%
Pressure:	1010hPa	Phase:	L
Test Voltage:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 1

				4	
Meter Reading	Factor	Emission Level	Limits	Margin	Domork
(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Remark
42.61	9.61	52.22	65.15	-12.93	QP
11.22	9.61	20.83	55.15	-34.32	AVG
36.45	9.68	46.13	56.00	-9.87	QP
27.90	9.68	37.58	46.00	-8.42	AVG
36.94	9.70	46.64	56.00	-9.36	QP
25.86	9.70	35.56	46.00	-10.44	AVG
35.15	9.75	44.90	56.00	-11.10	QP
23.61	9.75	33.36	46.00	-12.64	AVG
36.91	9.80	46.71	60.00	-13.29	QP
24.16	9.80	33.96	50.00	-16.04	AVG
40.01	10.04	50.05	60.00	-9.95	QP
20.18	10.04	30.22	50.00	-19.78	AVG
	(dBµV) 42.61 11.22 36.45 27.90 36.94 25.86 35.15 23.61 36.91 24.16 40.01	(dBµV) (dB) 42.61 9.61 11.22 9.61 36.45 9.68 27.90 9.68 36.94 9.70 25.86 9.70 35.15 9.75 23.61 9.75 36.91 9.80 24.16 9.80 40.01 10.04	(dBμV) (dB) (dBμV) 42.61 9.61 52.22 11.22 9.61 20.83 36.45 9.68 46.13 27.90 9.68 37.58 36.94 9.70 46.64 25.86 9.70 35.56 35.15 9.75 44.90 23.61 9.75 33.36 36.91 9.80 46.71 24.16 9.80 33.96 40.01 10.04 50.05	(dBμV) (dB) (dBμV) (dBμV) 42.61 9.61 52.22 65.15 11.22 9.61 20.83 55.15 36.45 9.68 46.13 56.00 27.90 9.68 37.58 46.00 36.94 9.70 46.64 56.00 25.86 9.70 35.56 46.00 35.15 9.75 44.90 56.00 23.61 9.75 33.36 46.00 36.91 9.80 46.71 60.00 24.16 9.80 33.96 50.00 40.01 10.04 50.05 60.00	(dBμV) (dB) (dBμV) (dBμV) (dBμV) 42.61 9.61 52.22 65.15 -12.93 11.22 9.61 20.83 55.15 -34.32 36.45 9.68 46.13 56.00 -9.87 27.90 9.68 37.58 46.00 -8.42 36.94 9.70 46.64 56.00 -9.36 25.86 9.70 35.56 46.00 -10.44 35.15 9.75 44.90 56.00 -11.10 23.61 9.75 33.36 46.00 -12.64 36.91 9.80 46.71 60.00 -13.29 24.16 9.80 33.96 50.00 -16.04 40.01 10.04 50.05 60.00 -9.95

Remark:

- All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.

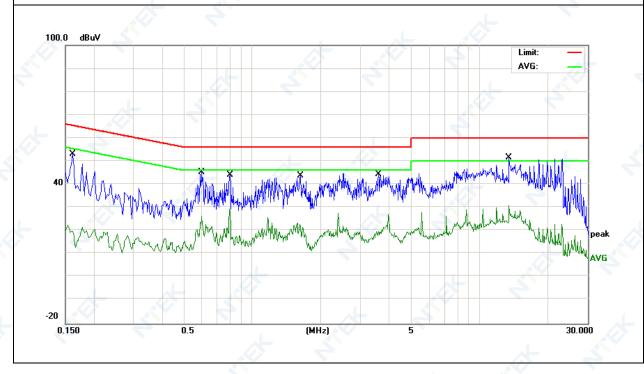




			4
EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21.5℃	Relative Humidity:	53%
Pressure:	1010hPa	Phase:	N
Test Voltage:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 1

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Damadı
(MHz)	(dBµV)	(dB)	(dBµV)	(dBµV)	(dB)	Remark
0.1620	43.34	9.65	52.99	65.36	-12.37	QP
0.1620	10.15	9.65	19.80	55.36	-35.56	AVG
0.5980	35.44	9.67	45.11	56.00	-10.89	QP
0.5980	16.75	9.67	26.42	46.00	-19.58	AVG
0.7980	34.38	9.68	44.06	56.00	-11.94	QP
0.7980	18.51	9.68	28.19	46.00	-17.81	AVG
1.6300	34.03	9.67	43.70	56.00	-12.30	QP
1.6300	12.55	9.67	22.22	46.00	-23.78	AVG
3.5900	34.49	9.71	44.20	56.00	-11.80	QP
3.5900	9.93	9.71	19.64	46.00	-26.36	AVG
13.5300	41.46	10.00	51.46	60.00	-8.54	QP
13.5300	20.80	10.00	30.80	50.00	-19.20	AVG

- All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.



3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT (Below 1000MHz)

Table A.2 – Requirements for radiated emissions at frequencies up to 1 GHz for Class A equipment

Table clause	Frequency range	N	leasurement	Class A limits dB(μV/m)	
Clause	MHz	Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)	
A2.1	30 – 230	10	70	40	
	230 – 1 000		Quasi Peak /	47	
A2.2	30 – 230		120 kHz	50	
	230 – 1 000	3		57	

Apply only A2.1 or A2.2 across the entire frequency range.

Table A.4 – Requirements for radiated emissions at frequencies up to 1 GHz for Class B equipment

Table clause	Frequency range	Measurement		Class B limits dB(μV/m)	
	MHz	Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)	
A4.1	30 – 230	40		30	
	230 – 1 000	10	Quasi Peak /	37	
A4.2	30 – 230		120 kHz	40	
230 – 1 000	3		47		

Apply only table clause A4.1 or A4.2 across the entire frequency range.

Table A.6 - Requirements for radiated emissions from FM receivers

Table	Frequency range	Measurement		Class B limit dB(μV/m)	
clause	MHz	Distance	Detector type/	Fundamental	Harmonics
	m bandwid	bandwidth	OATS/SAC (see Table A.1) (see		
A6.1	30 – 230	<i>*</i>	.0 _2	1	42
	230 – 300	10	10 50	50	42
1	300 – 1 000		Quasi peak/		46
A6.2	30 – 230		120 kHz		52
	230 – 300	3	7	60	52
	300 – 1 000		-		56

Apply only A.6.1 or A.6.2 across the entire frequency range.

These relaxed limits apply only to emissions at the fundamental and harmonic frequencies of the local oscillator. Signals at all other frequencies shall be compliant with the limits given in Table A.4.



3.2.2 LIMITS OF RADIATED EMISSION MEASUREMENT (Above 1000MHz)

Table A.3 – Requirements for radiated emissions at frequencies above 1 GHz for Class A equipment

Table clause	Frequency range	Measurement		Class A limits dB(μV/m)	
	MHz	Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)	
A3.1	1 000 – 3 000		Average /	56	
	3 000 – 6 000		1 MHz	60	
A3.2	1 000 – 3 000	3	Peak /	76	
	3 000 – 6 000		1 MHz	80	

Apply A3.1 and A3.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

Table A.5 – Requirements for radiated emissions at frequencies above 1 GHz for Class B equipment

Table clause	Frequency range	Measurement		Class B limits dB(μV/m)	
	MHz	Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)	
A5.1	1 000 – 3 000		Average/	50	
	3 000 – 6 000		1 MHz	54	
A5.2	1 000 – 3 000	3	Peak/	70	
	3 000 – 6 000		1 MHz	74	

Apply A5.1 and A5.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

Notes:

- (1) The limit for radiated test was performed according to as following: CISPR 32.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBμV/m)=20log Emission level (uV/m).

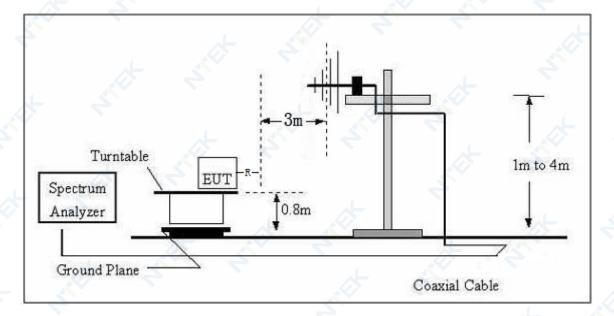


3.2.3 TEST PROCEDURE

- a. The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item -EUT Test Photos.

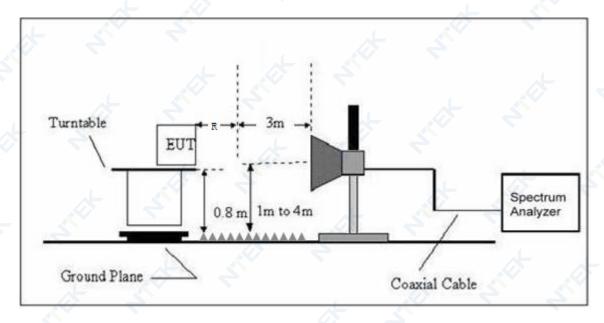
3.2.4 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz





(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.



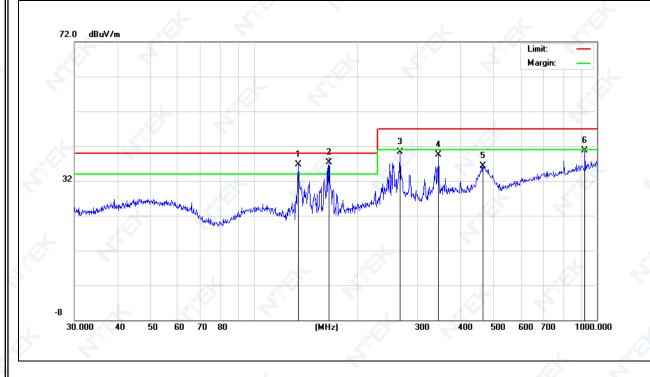
3.2.6 TEST RESULTS (30-1000MHz)

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	25.5℃	Relative Humidity:	53%
Pressure:	1010 hPa	Polarization:	Horizontal
Test Power:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 2-battery 1

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Domork
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Remark
134.5592	21.29	15.32	36.61	40.00	-3.39	QP
165.4866	21.62	15.68	37.30	40.00	-2.70	QP
266.6089	20.79	19.43	40.22	47.00	-6.78	QP
345.5952	18.34	21.17	39.51	47.00	-7.49	QP
465.5994	13.43	22.92	36.35	47.00	-10.65	QP
922.5157	11.44	29.32	40.76	47.00	-6.24	QP

Remark:

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.

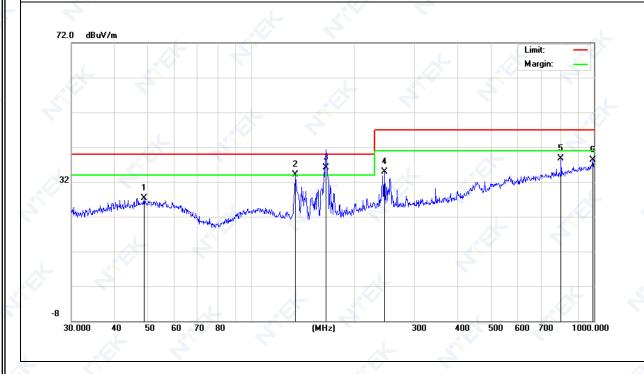




			4
EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	25.5℃	Relative Humidity:	53%
Pressure:	1010 hPa	Polarization:	Vertical
Test Power:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 2-battery 1

Frequency	Meter Reading	Factor	or Emission Level Limits Margin		Margin	Remark
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Remark
48.8429	6.48	20.86	27.34	40.00	-12.66	QP
134.5592	18.80	15.32	34.12	40.00	-5.88	QP
165.3067	20.46	15.68	36.14	40.00	-3.86	QP
245.0900	15.81	19.05	34.86	47.00	-12.14	QP
801.7863	10.76	27.88	38.64	47.00	-8.36	QP
993.0114	8.26	30.00	38.26	47.00	-8.74	QP

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.

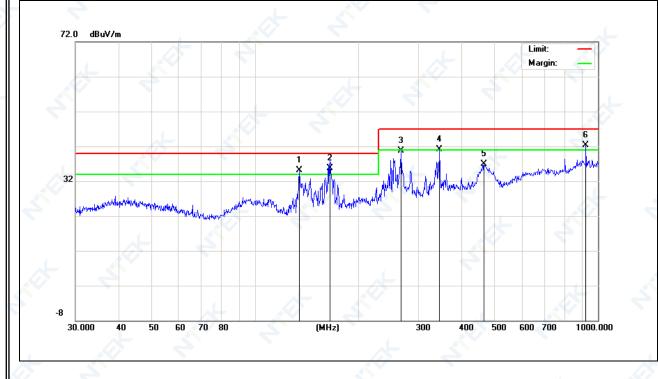




			<u> </u>
EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	25.5℃	Relative Humidity:	53%
Pressure:	1010 hPa	Polarization:	Horizontal
Test Power:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 2-battery 2

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Domork
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Remark
134.5592	19.79	15.32	35.11	40.00	-4.89	QP
165.4866	20.12	15.68	35.80	40.00	-4.20	QP
266.6089	21.29	19.43	40.72	47.00	-6.28	QP
345.5951	19.84	21.17	41.01	47.00	-5.99	QP
465.5994	13.93	22.92	36.85	47.00	-10.15	QP
922.5157	12.94	29.32	42.26	47.00	-4.74	QP

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.

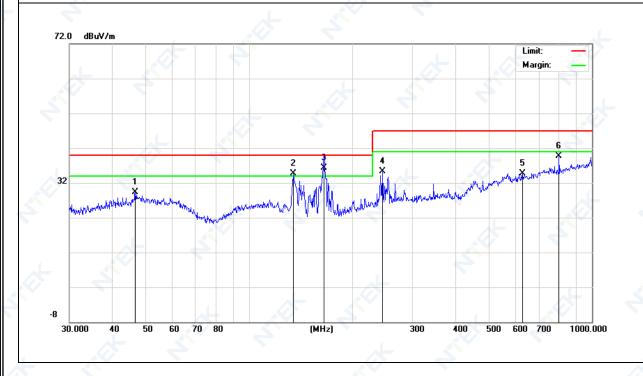




			4
EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	25.5℃	Relative Humidity:	53%
Pressure:	1010 hPa	Polarization:	Vertical
Test Power:	DC 5V from adapter AC 230V/50Hz	Test Mode:	Mode 2-battery 2

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Domork
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Remark
46.6664	8.52	20.72	29.24	40.00	-10.76	QP
134.5592	19.30	15.32	34.62	40.00	-5.38	QP
165.4866	20.62	15.68	36.30	40.00	-3.70	QP
245.0900	16.31	19.05	35.36	47.00	-11.64	QP
627.2738	9.17	25.56	34.73	47.00	-12.27	QP
801.7862	11.76	27.88	39.64	47.00	-7.36	QP

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.



3.2.7 TEST RESULTS(1000-6000MHz)

EUT:	Tablet PC	Model Name:	Tab 8 WiFi	
Temperature:	25.3℃	Relative Humidity:	53%	
Pressure:	1010 hPa	Mode 1		
Test Power:	DC 5V from adapter AC 230V/50Hz			

Polar	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Remark
(H/V)	(MHz)	(dBµV/m)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	
V	1336.782	37.95	7.60	45.55	70.00	-24.45	peak
٧	2312.995	35.79	9.83	45.62	70.00	-24.38	peak
V	3994.946	35.65	14.30	49.95	74.00	-24.05	peak
V	4753.260	34.88	16.01	50.89	74.00	-23.11	peak
V	5143.163	34.37	17.12	51.49	74.00	-22.51	peak
V	5925.216	33.82	18.81	52.63	74.00	-21.37	peak
Н	2761.924	35.42	11.18	46.60	70.00	-23.40	peak
H	3692.090	36.25	13.30	49.55	74.00	-24.45	peak
Н	4052.622	35.34	14.44	49.78	74.00	-24.22	peak
Н	4744.751	35.55	15.98	51.53	74.00	-22.47	peak
Н	5097.292	34.97	17.09	52.06	74.00	-21.94	peak
Щ	5685.998	35.12	17.84	52.96	74.00	-21.04	peak
Remar	k:				4		*

Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit

Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.



3.3 HARMONICS CURRENT

3.3.1LIMITS OF HARMONICS CURRENT

Table 1 – Limits for Class A equipment

Harmonic order (n)	Maximum permissible harmonic current (A)		
Odd I	narmonics		
3	2.3		
5	1.14		
7	0.77		
9	0.4		
11	0.33		
13	0.21		
15≤n≤39	0.15*(15/n)		
Even	harmonics		
2	1.08		
4	0.43		
6	0.30		
8≤n≤40	0.23*(8/n)		

Note: Reference standard of the table above: EN61000-3-2.



3.3.2 TEST PROCEDURE

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.
- b. The classification of EUT is according to section 5 of EN 61000-3-2. The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools. Portable tools.; Arc welding equipment which is not professional equipment.

Class C: Lighting equipment.

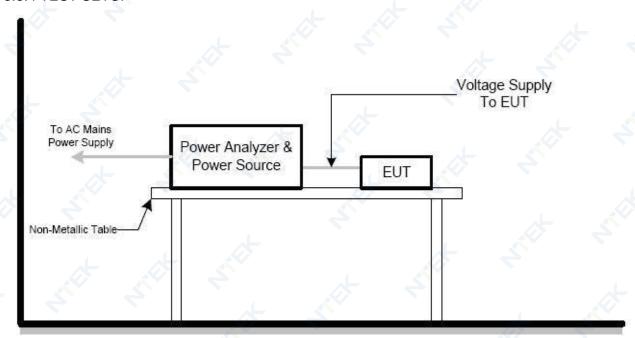
Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television receivers.

c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

3.3.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

3.3.4 TEST SETUP







3.3.5 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	19℃	Relative Humidity:	50%
Pressure:	1012hPa	Test duration:	150s
Classification:	Class A	Test Power:	N/A
Test Mode:	N/A	.1	* ?

Note: The active input power of the EUT is less than 75 W. No limits apply for equipment with an active input power up to and including 75W.



3.4 VOLTAGE FLUCTUATION AND FLICKERS

3.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKERS

Test items	Limits(EN61000-3-3)	Descriptions
P _{st}	≤1.0, T _p =10min	short-term flicker indicator
P _{lt}	≤0.65, T _p =2h	long-term flicker indicator
d _c	≤3.3%	relative steady-state voltage change
d _{max}	≤4%(or 6% _{Note(1)} , 7% _{Note(2)})	maximum relative voltage change:
d _(t)	≤3.3%, more than 500ms	relative voltage change characteristic

Note:

- 1. 6 % for equipment which is:
 - a. switched manually, or
 - b. switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.
- 2. 7 % for equipment which is
 - a. attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or b. switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

3.4.2 TEST PROCEDURE

a. Harmonic Current Test:

Test was performed according to the procedures specified in Sub-clause 6.2 of IEC/EN 61000-3-2 depend on which standard adopted for compliance measurement.

b. Fluctuation and Flickers Test:

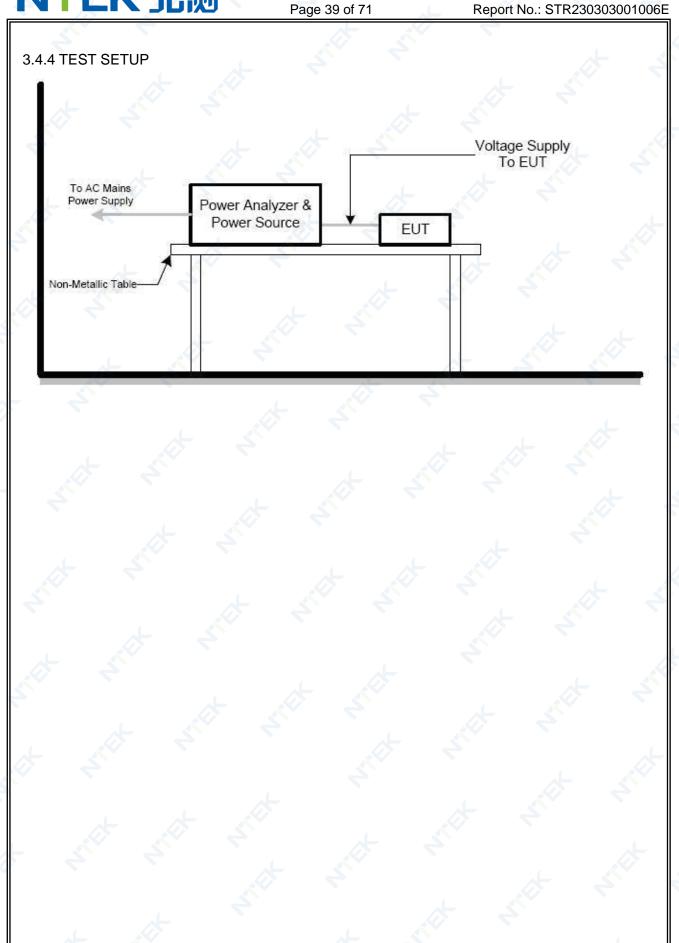
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.

c. All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.









3.4.5 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	20℃	Relative Humidity:	50%
Pressure:	1010 hPa	Hest Power.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1	,	A- 3

*	EUT values	Limit	Result
Pst	0.016	5.00	PASS
Plt	0.007	0.65	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.000	4.00	PASS
Tmax [s]	0.000	0.50	PASS



4. EMC IMMUNITY TEST

4.1 GENERAL PERFORMANCE CRITERIA

4.1.1 PERFORMANCE CRITERIA

According to EN 55035 standard, the general performance criteria as following:

is used as intended. The performance level may be replaced by a permissible loss of performance lift the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		
below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		The equipment shall continue to operate as intended without operator
is used as intended. The performance level may be replaced by a permissible loss of performance lift the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		intervention. No degradation of performance or loss of function is allowed
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If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be	.0	is used as intended.
specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be	Criterion A	The performance level may be replaced by a permissible loss of performance.
product description and documentation, and by what the user may reasonably expect from the equipment if used as intended. After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		If the minimum performance level or the permissible performance loss is not
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operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		expect from the equipment if used as intended.
allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		After the test, the equipment shall continue to operate as intended without
Criterion B specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		operator intervention. No degradation of performance or loss of function is
The performance level may be replaced by a permissible loss of performance During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be	4	allowed, after the application of the phenomena below a performance level
During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be	Criterion B	specified by the manufacturer, when the equipment is used as intended.
operating state or stored data is allowed to persist after the test. Loss of function is allowed, provided the function is self-recoverable, or can be		The performance level may be replaced by a permissible loss of performance.
Loss of function is allowed, provided the function is self-recoverable, or can be		During the test, degradation of performance is allowed. However, no change of
		operating state or stored data is allowed to persist after the test.
restored by the operation of the controls by the user in accordance with the	ـ ــــــــــــــــــــــــــــــــــــ	Loss of function is allowed, provided the function is self-recoverable, or can be
restarted by the operation of the second by the second		restored by the operation of the controls by the user in accordance with the
Criterion C manufacturer's instructions.	Criterion C	manufacturer's instructions.
Functions, and/or information stored in non-volatile memory, or protected by a		Functions, and/or information stored in non-volatile memory, or protected by a
battery backup, shall not be lost.		battery backup, shall not be lost.

According to EN 301 489-3 standard, the general performance criteria as following:

Criteria	During the test	After the test					
	Operate as intended	Operate as intended					
	No loss of function	No loss of function					
Α	No unintentional responses	No degradation of performance					
*	A 100	No loss of stored data or user programmable					
		functions					
	7	Operate as intended					
	May show loss of function	Lost function(s) shall be self-recoverable					
В	May show loss of function	No degradation of performance					
	No unintentional responses	No loss of stored data or user programmable					
		functions					



According to EN 301489-17 standard, the general performance criteria as following:

Criteria	During the test	After the test
	Shall operate as intended (see note 1).	Shall operate as intended.
	Shall be no loss of function.	Shall be no degradation of performance
Α	Shall be no unintentional transmissions	(see note 3).
	A	Shall be no loss of function.
	4	Shall be no loss of stored data or user
		programmable functions
		Functions shall be self-recoverable.
	May show loss of function (one or more).	Shall operate as intended after recovering.
В	May show degradation of performance	Shall be no degradation of performance
	(see note 2).	(see note 3).
	Shall be no unintentional transmissions.	Shall be no loss of stored data or user
	L X	programmable functions.
	10	Functions shall be recoverable by the
	*	operator.
С	May be loss of function (one or more)	Shall operate as intended after recovering.
		Shall be no degradation of performance
	+ 3	(see note 3).

NOTE 1: Operate as intended during the test allows a level of degradation not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 3: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.



PERFORMANCE FOR TT

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR TR

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CT

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CR

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

4.2 GENERAL PERFORMANCE CRITERIA TEST SETUP

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.



4.3 ESD TESTING

4.3.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance	В
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV
	Contact Discharge: 2kV/4kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point
	Contact Discharge: min. 200 times in total
Discharge Mode:	A/C Discharge
Discharge Period:	1 second minimum

4.3.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. Indirect application of the discharge:

Vertical Coupling Plane (VCP):

At least 10 single discharges (in the most sensitive polarity) shall be applied to the centre of one vertical edge of the coupling plane. The coupling plane, of dimensions $0.5 \text{ m} \times 0.5 \text{ m}$, is placed parallel to, and positioned at a distance of 0.1 m from, the EUT.

Discharges shall be applied to the coupling plane, with sufficient different positions such that the four faces of the EUT are completely illuminated. One VCP position is considered to illuminate $0.5 \text{ m} \times 0.5 \text{ m}$ area of the EUT surface.

Horizontal Coupling Plane (HCP):

Discharge to the HCP shall be made horizontally to the edge of the HCP.

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the centre point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

The discharge electrode shall be in contact with the edge of the HCP before the discharge switch is operated

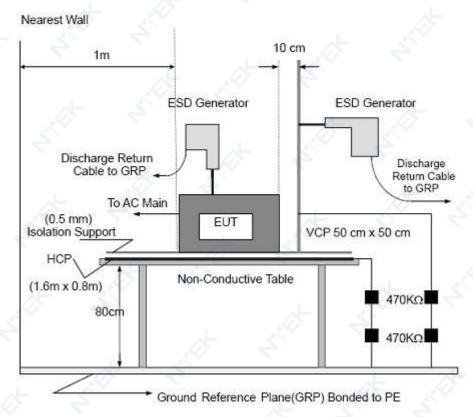
b. Direct application of discharges to the EUT

The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied.

For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.



4.3.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



4.3.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	19℃	Relative Humidity:	50%
Pressure:	1010 hPa	LIAST POWAR.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6	4	¥ 3,

Mode		Contac	ct Discl		<i>A</i>				
Test level(kV)	Test	2	2	4	4	(6	Criterion	Result
Test Location	Point	+	-	+	- 1	+	-0		
* 3	Front	Р	Р	Р	Р				
НСР	Rear	Р	Р	Р	Р				
ПСР	Left	Р	Р	Р	Р				
	Right	Р	Р	Р	Р			В	Complies
	Front	Р	Р	Р	Р	-		Б	Complies
VCP	Rear	Р	Р	Р	Р				.(_
VCP	Left	Р	Р	Р	Р		. 1		
* *	Right	Р	Р	Р	Р				4

Mode 4/5/6

WIDGE 4/J/	<u>, </u>																		
Mode			Air	Dis	cha	rge				Co	onta	ct [Disc	har	ge				3
Test level(kV)	2	2	4	1	8	3	1	5	2	2	4	4	(3	3	3	Obser vation	Criterion	Result
Test Location	+	-	+	1	+	-	+	1	+	3	+	-	+		+	-			
A1	Р	Р	Р	Р	Р	P													
A2	Р	Р	Р	Р	Р	Р											4		
A3	Р	Р	Р	Р	Р	Р							0						
A4	Р	Р	Р	Р	Р	Р											TTŤD	P	Complies
A5	Р	Р	Р	Р	Р	Р		1						4			TT,TR	В	Complies
A6	Р	Р	Р	Р	Р	Р							4						٨,
A7	Ρ	Р	Р	Ρ	Р	Р											*	ے.	
A8	Р	Р	Р	Р	Р	Р											4		4



Mode 1/2/3

Mode		d	Air	Dis	cha	rge				Co	onta	ct [Disc	har	ge		4	7
Test level(kV)		2	4	1		3	1	5	2	2	4	4	O	ŝ	8		Criterion	Result
Test Location	+	-	+	-	+	الله	+	1	+	-	+		+	-	+	-		d
A1	Р	Р	Р	Р	P	Р												
A2	Р	Р	Р	Р	Р	Р												
А3	Р	Р	Р	Р	Р	Р					•							
A4	Р	Р	Р	Р	Р	Р											L D /	Complian
A5	Р	Р	Ρ	P	Р	Р											В	Complies
A6	Р	Р	Р	Р	Р	Р							,		1			
A7	Р	Р	Р	Р	Р	Р												
A8	Р	Р	Р	Р	Р	Р)										

Note:

- 1) +/- denotes the Positive/Negative polarity of the output voltage.
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.



4.3.5 PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED



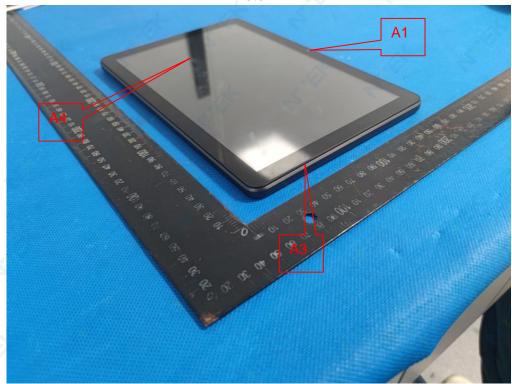
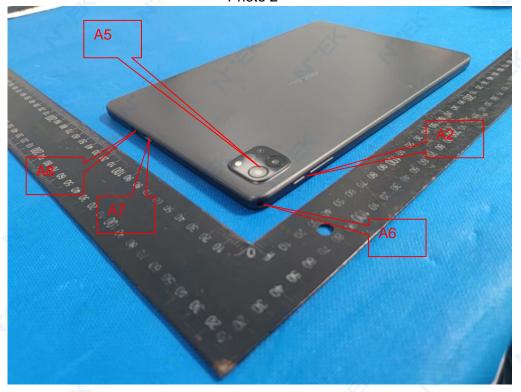


Photo 2





4.4 RS TESTING

4.4.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-3						
Required Performance	A						
Frequency Range:	According to EN 301 489-1:						
	80 MHz - 6000 MHz ;						
	According to EN 55035:						
* 3	80 MHz to 1000 MHz						
*	1800 MHz						
	2600 MHz						
4	3500 MHz						
* *	5000 MHz						
Field Strength:	3 V/m						
Modulation:	1kHz Sine Wave, 80%, AM Modulation						
Frequency Step:	1 % of fundamental						
Polarity of Antenna:	Horizontal and Vertical						
Test Distance:	3 m						
Antenna Height:	1.5 m						
Dwell Time:	at least 3 seconds						

4.4.2 TEST PROCEDURE

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

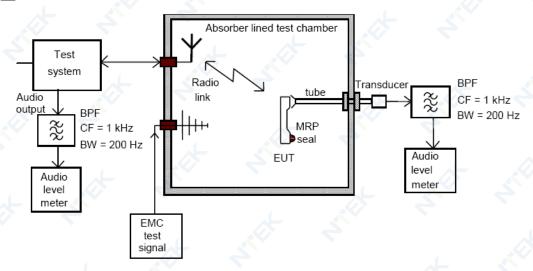
The other condition as following manner:

- a. The field strength level was 3V/m.
- b. The frequency range is swept from 80 MHz to 6000 MHz, 1800 MHz, 2600 MHz, 3500 MHz, and 5000 MHz with the signal 80%amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. Sweep Frequency 900 MHz, with the Duty Cycle:1/8 and Modulation: Pulse 217 Hz(if applicable)
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

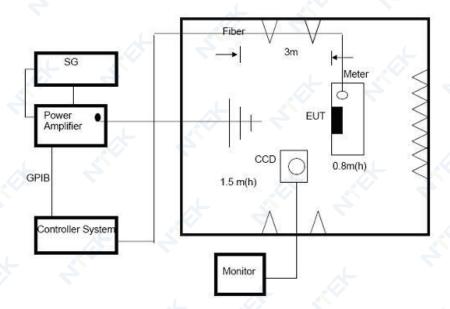


4.4.3 TEST SETUP

Mobile Communication



□ General Communication



Note:

For the actual test configuration, please refer to the related Item -EUT Test Photos.

TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



4.4.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	24 ℃	Relative Humidity:	58%
Pressure:	1010 hPa	Test Power:	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6	4	* 3

TEST RESULT

Mode 4/5/6

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Perform. Criteria	Results
7		*	Front			
.1			Rear			, L
	H/V	3 V/m (rms) AM Modulated	Left	. (_		
80 ~ 1000			Right	CT,CR	Α -	Р
3		1000Hz, 80%	Тор	4	· ·	
•	4		Bottom			4

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Perform. Criteria	Results
			Front			
1	H/V		Rear			
		3 V/m (rms)	Left		,	
1000 ~ 6000		AM Modulated	Right	CT,CR	Α	P
	491	1000Hz, 80%	Тор			
4	7		Bottom			

Note:

1. The exclusion band has not been tested in 80MHz ~ 6GHz.

The exclusion band for immunity testing of equipment operating in the 2.4 GHz band shall be: • lower limit of exclusion band = lowest allocated band edge frequency -120 MHz, i.e. 2 280 MHz; • upper limit of exclusion band = highest allocated band edge frequency +120 MHz, i.e. 2 603,5MHz.

2. "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.



Mode 1/2/3

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform. Criteria	Results
80 ~ 1000			Front		
1000 ~ 6000	ب ح		Rear		
		3 V/m (rms)	Left		
1800	H/V	AM Modulated	Right	Α	Р
2600		1000Hz, 80%	Тор		
3500		1.0001.12, 0070	•		大
5000			Bottom		

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

Note:

- 1) N/A denotes test is not applicable in this test report.
- 2) There was not any unintentional transmission in standby mode
- 3) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.



4.5 EFT/BURST TESTING

4.5.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-4				
Required Performance	В				
Test Voltage:	Power Line: 1 kV				
	DC/Signal/ wired network Line: 0.5 KV				
Polarity:	Positive & Negative				
Impulse Frequency:	For xDSL wired network ports: 100 kHz				
+ **	For DC/AC ports: 5 kHz				
Impulse Wave shape :	5/50 ns				
Burst Duration:	15 ms				
Burst Period:	300 ms				
Test Duration:	Not less than 1 min.				

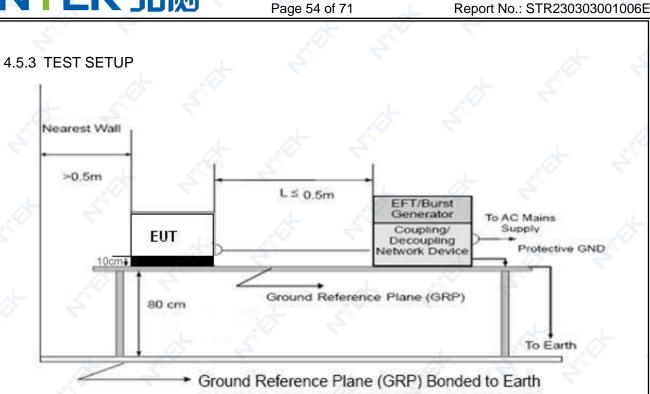
4.5.2 TEST PROCEDURE

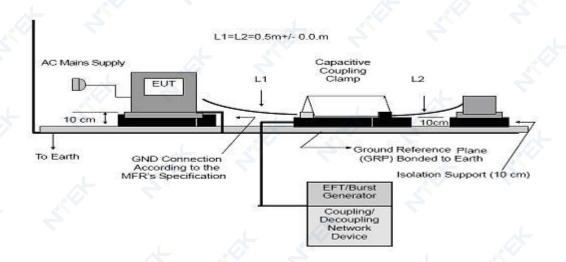
The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

- The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minute
- d. For the actual test configuration, please refer to the related Item -EUT Test Photos.







Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-4 and its cables were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.





4.5.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21℃	Relative Humidity:	53%
Pressure:	1010 hPa	Hest Bower.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6	4	* 4

TEST RESULT

Mode 4/5/6

Coupling Line		Test level (kV)							Observation	Criterion	Result	
Cou	piirig Line	0.	.5	1		2		4		Observation	Cillenon	Result
		+	-	+	-	+	-	+	-		*	
	L	Р	Р	Р	Р					<u></u>	4	Complies
	N	Р	Р	Р	Р				,	4		Complies
AC	PE						7					*
line	L+N	Р	Р	Р	Р					A .		Complies
	L+PE							,		TT,TR	В	
	N+PE											
	L+N+PE	4										
D	C Line						ا لم	*				
Sig	ınal Line											4





Mode 1/2/3

141006 17213	'										
			Te	est lev	*						
Coupling Line		0	0.5		1		2		4	Criterion	Result
		+	+	+		+		+	-		٠ ا
	,L	Р	Р	Р	Р					L .	Complies
	N	Р	Р	Р	Р					4	Complies
	PE				X						/
AC line	L+N	Р	Р	Р	Р						Complies
	L+PE									В	
	N+PE										
	L+N+PE										_ 1
DC Line									ے ک		
Signal Line											4
		1									

Note:

- 1)There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.



4.6 SURGE TESTING

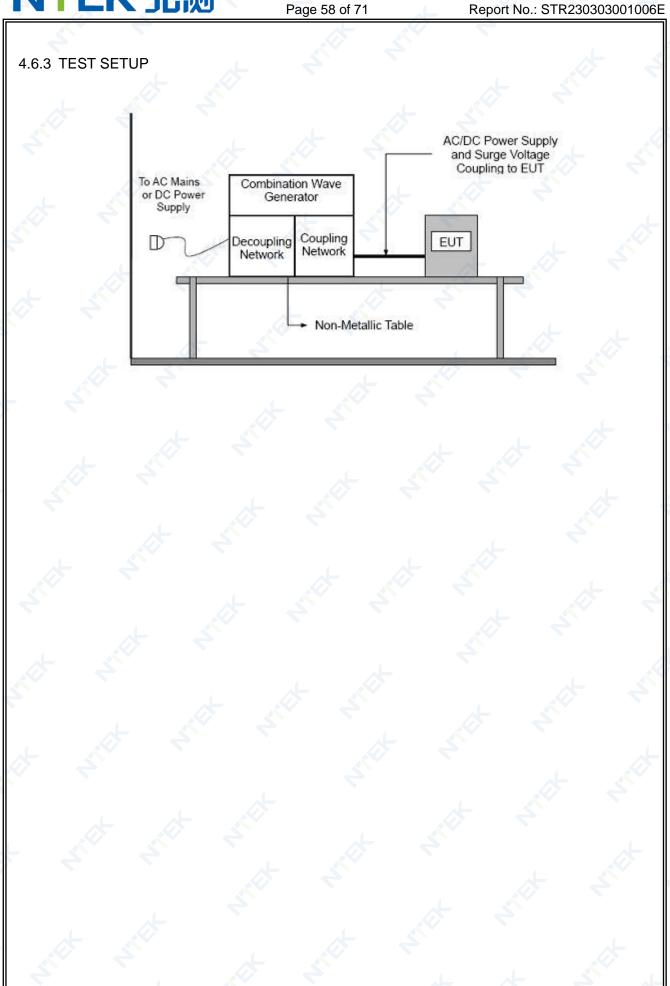
4.6.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-5
Required Performance	В
Wave-Shape:	Combination Wave
	1.2/50 us Open Circuit Voltage
>	8 /20 us Short Circuit Current
Test Voltage:	Power Line:0.5 kV, 1 kV, 2 kV
Surge Input / Output:	L-N, L-PE, N-PE
Generator Source:	2 ohm between networks
Impedance:	12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0 /90/180/270
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

4.6.2 TEST PROCEDURE

- a. For EUT power supply:
 - The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).
- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT: The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:
 - The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- d. For the actual test configuration, please refer to the related Item -EUT Test Photos.









4.6.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21℃	Relative Humidity:	53%
Pressure:	1010 hPa	HEST POWEL.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6		* 4

TEST RESULT

Mode 4/5/6

	41010				-	Test I	evel				*		4
<u>_</u>	Coupling Line		0.5 kV		1 kV		2 kV		4 kV		Observation	Criterion	Result
			+	-	+	4	+	- 4	+	-			
		0°	Р	Р	Р	Р							<i>*</i>
	L-N	90°	Р	Р	Р	Р						4	
	L-IN	180°	Р	Р	Р	Р					3		
		270°	Р	Р	Р	Р	4						
		0°	ــــــــــــــــــــــــــــــــــــ	*									
AC	L-PE	90°									TT,TR	В	Complies
line	L-1 L	180°								5			<u> </u>
		270°											
		0°									*		
	N-PE	90°											
		180°							4		4		J .
		270°				5					从		
	DC Line												
	Signal Line)											



Mode 1/2/3

			Test level			J 5						
Coupling Line		0.5	kV	1	kV	2	kV	4	kV	Criterion	Result	
			+	1	+	-	+	-	+	-		,L 4
	4	0°	Р	Р	Р	Р					L .4	
ے ا	I NI	90°	Р	Р	Р	Р		×			× 4	Complies
	L-N	180°	Р	Р	Р	Р			4			
		270°	P	Р	Р	Р						
	L-PE N-PE	0°									В	
A C lin a		90°			4				•			
AC line		180°				•						
		270°										
		0°					٦.					4,
4		90°										
v		180°										*
4		270°	4									
	DC Line											
- 8	Signal Line											

Note:

- 1) There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.



4.7 INJECTION CURRENT TESTING

4.7.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-6
Required Performance	A
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3 Vr.m.s.
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	at least 3 seconds

4.7.2 TEST PROCEDURE

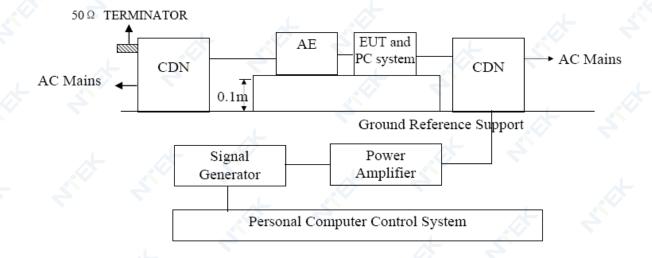
The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

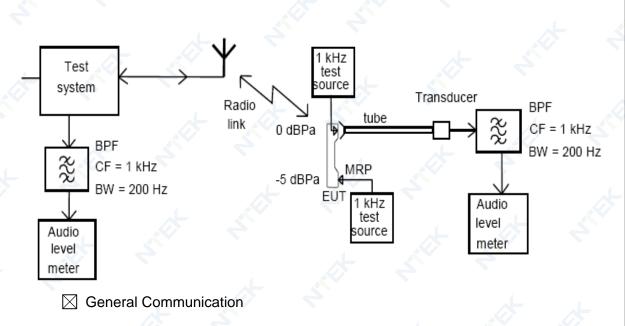
- a. The field strength level was 3V.
- b. The frequency range is swept from 150 KHz to 80 MHz, with the signal 80%amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. For the actual test configuration, please refer to the related Item -EUT Test Photos.

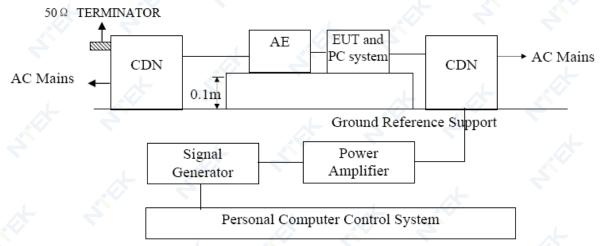
4.7.3 TEST SETUP

Mobile Communication









For the actual test configuration, please refer to the related Item –EUT Test Photos.

NOTE:

FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.



4.7.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21℃	Relative Humidity:	53%
Pressure:	1010 hPa	Hest bower.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6		¥

TEST RESULT

Mode 4/5/6

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Observation	Perform. Criteria	Results
Input/ Output AC. Power Port	0.1580	3V(rms)	CT, CR	A	P
Input/ Output DC. Power Port	0.15 80	AM Modulated	N/A	N/A	N/A
Signal Line	0.15 80	1000Hz, 80%	CT, CR	A	P

Mode 1/2/3

Test Ports (Mode)	Freq. Range (MHz)	Field Strength	Perform. Criteria	Results
Input/ Output AC. Power Port	0.1580	2)//rma)	A	P
Input/ Output DC. Power Port	0.15 80	3V(rms) AM Modulated	N/A	N/A
Signal Line	0.15 80	1000Hz, 80%	N/A	N/A

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.



4.8 VOLTAGE INTERRUPTION/DIPS TESTING

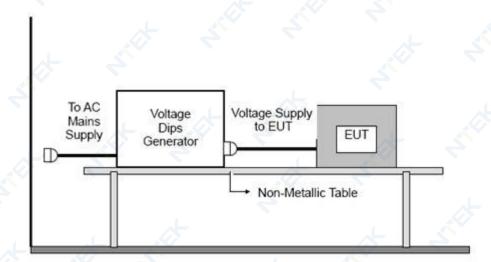
4.7.5 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11
AL-	100% reduction, 0.5 Cycle
Required Performance	100% reduction, 1.0 Cycle
W 4	30% reduction, 25 Cycles
Voltage Interruptions:	100% reduction, 250 Cycles
Test Duration Time:	Minimum three test events in sequence
Interval between Event:	Minimum ten seconds
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°
Test Cycle:	3 times

4.8.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

4.8.3 TEST SETUP



For the actual test configuration, please refer to the related Item –EUT Test Photos.



4.8.4 TEST RESULTS

EUT:	Tablet PC	Model Name:	Tab 8 WiFi
Temperature:	21℃	Relative Humidity:	53%
Pressure:	1010 hPa	Hest bower.	DC 5V from adapter AC 230V/50Hz
Test Mode:	Mode 1/2/3/4/5/6		

TEST RESULT

Mode 4/5/6

Voltage Reduction	Duration (ms)	Observation	Perform Criteria	Results
Voltage dip: 0%	10	TT, TR	В	Р
Voltage dip: 0%	20	TT, TR	В	Р
Voltage dip: 70%	500	TT, TR	С	Р
Voltage interruptions: 0%	5000	TT, TR	F C	Р

Mode 1/2/3

Voltage Reduction	Duration (ms)	Perform Criteria	Results	
Voltage dip: 0%	10	В	Р	
Voltage dip: 0%	20	В	Р	
Voltage dip: 70%	500	С	Р	
Voltage interruptions: 0%	5000	С	P	

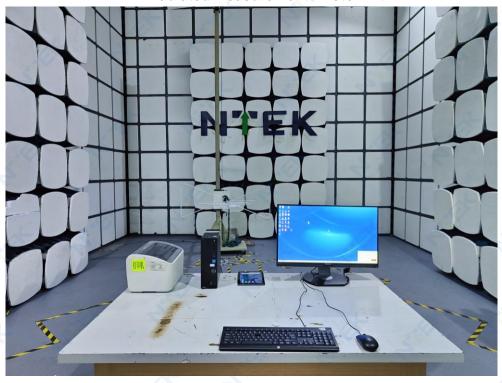
Note:

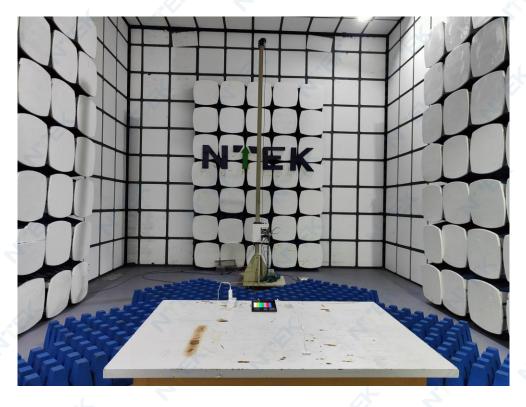
- 1) There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.



5. EUT TEST PHOTO

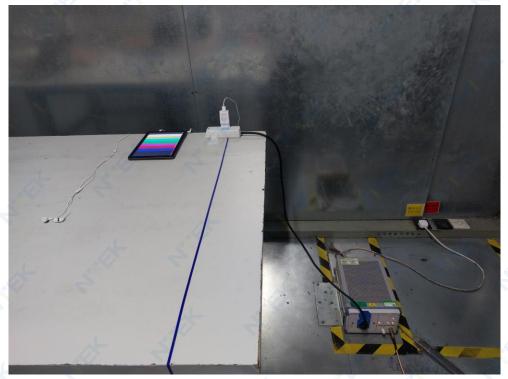
Radiated Measurement Photo













Flick Measurement Photo



ESD Measurement Photo









EFT Measurement Photo







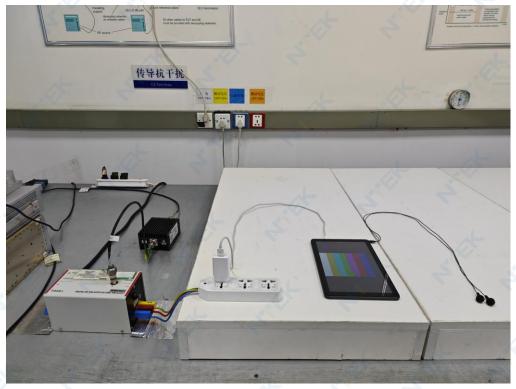


DIP Measurement Photo









END OF REPORT